



# FQA6N70

## 700V N-Channel MOSFET

## **General Description**

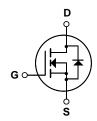
These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology is especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation modes. These devices are well suited for high efficiency switch mode power supply.

#### **Features**

- 6.4A, 700V, R<sub>DS(on)</sub> = 1.5  $\Omega$  @ V<sub>GS</sub> = 10 V • Low gate charge ( typical 30 nC)
- Low Crss (typical 15 pF)
- Fast switching
- 100% avalanche tested
- · Improved dv/dt capability





# Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQA6N70	Units	
V <sub>DSS</sub>	Drain-Source Voltage		700	V	
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°C)		6.4	Α	
	- Continuous (T <sub>C</sub> = 100°C)		4.05	Α	
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	25.6	Α	
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V	
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	600	mJ	
I <sub>AR</sub>	Avalanche Current	(Note 1)	6.4	Α	
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	15.2	mJ	
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns	
P <sub>D</sub>	Power Dissipation (T <sub>C</sub> = 25°C)		152	W	
	- Derate above 25°C		1.22	W/°C	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C	
T <sub>L</sub>	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C	

# **Thermal Characteristics**

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.82	°C/W
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink	0.24		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		40	°C/W

Symbol	Parameter	Test Conditions	1	Min	Тур	Max	Units
Off Cha	aracteristics						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		700			V
ΔBV <sub>DSS</sub> / ΔΤ <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced	to 25°C		0.78		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 700 V, V <sub>GS</sub> = 0 V				10	μА
		V <sub>DS</sub> = 560 V, T <sub>C</sub> = 125°C				100	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$				100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$				-100	nA
On Cha	racteristics						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		3.0		5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 3.2 A			1.16	1.5	Ω
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = 50 \text{ V}, I_{D} = 3.2 \text{ A}$	(Note 4)		6.4		S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0  MHz			1100 125 15	1400 150 120	pF pF pF
					10	120	рг
t <sub>d(on)</sub>	Ing Characteristics Turn-On Delay Time	V - 250 V I - 6 2 A			25	60	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{DD}$ = 350 V, $I_{D}$ = 6.2 A, $R_{G}$ = 25 $\Omega$ (Note 4, 5)			70	150	ns
t <sub>d(off)</sub>	Turn-Off Delay Time				55	120	ns
t <sub>f</sub>	Turn-Off Fall Time				50	110	ns
Q <sub>g</sub>	Total Gate Charge	$V_{DS} = 560 \text{ V}, I_{D} = 6.2 \text{ A},$			30	40	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10 V (Note 4, 5)			6.5	-	nC
Q <sub>gd</sub>	Gate-Drain Charge				13		nC
Drain-S	Source Diode Characteristics ar	nd Maximum Ratings	S				
l <sub>S</sub>	Maximum Continuous Drain-Source Diode Forward Current					6.4	Α
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode F	Forward Current				25.6	Α
$V_{SD}$	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 6.4 \text{ A}$		-		1.4	V
t <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0 \text{ V}, I_{S} = 6.2 \text{ A},$		-	340	1	ns
$Q_{rr}$	Reverse Recovery Charge	$dI_F / dt = 100 A/\mu s$ (Note 4)			2.7		μC

- Notes: 
  1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 27.2mH,  $I_{AS}$  = 6.4A,  $V_{DD}$  = 50V,  $R_{G}$  = 25  $\Omega$ , Starting  $T_{J}$  = 25°C 3.  $I_{SD} \le 6.2A$ , di/dt  $\le 200A\mu_B$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_{J}$  = 25°C 4. Pulse Test : Pulse width  $\le 300\mu_B$ , Duty cycle  $\le 2\%$  5. Essentially independent of operating temperature

# **Typical Characteristics**

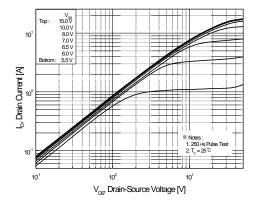


Figure 1. On-Region Characteristics

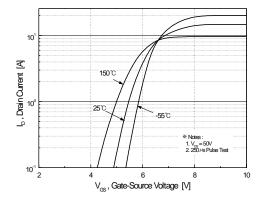


Figure 2. Transfer Characteristics

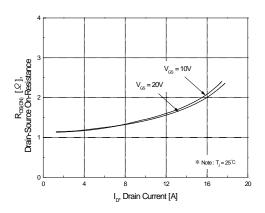


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

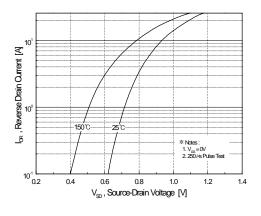


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

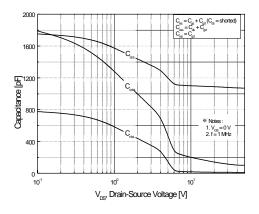


Figure 5. Capacitance Characteristics

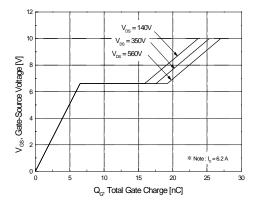
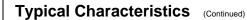


Figure 6. Gate Charge Characteristics

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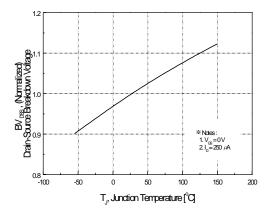
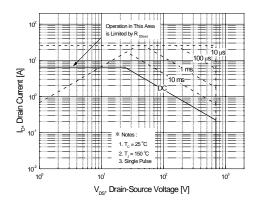


Figure 7. Breakdown Voltage Variation vs. Temperature

Figure 8. On-Resistance Variation vs. Temperature



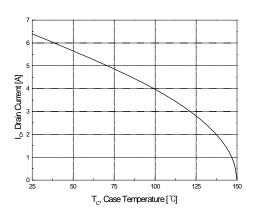


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

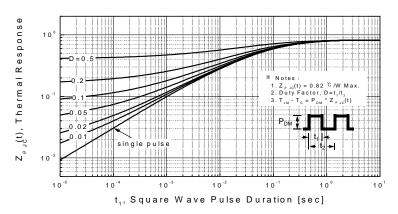
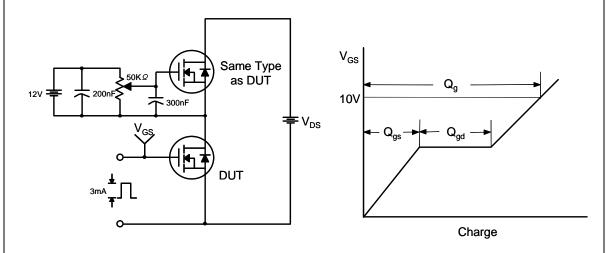


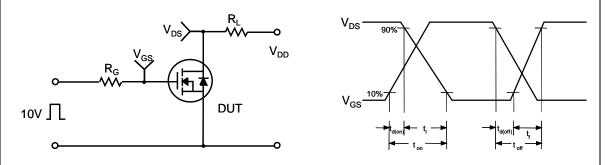
Figure 11. Transient Thermal Response Curve

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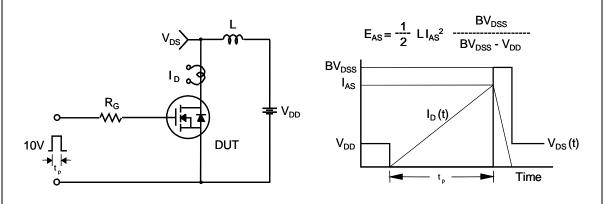
# **Gate Charge Test Circuit & Waveform**



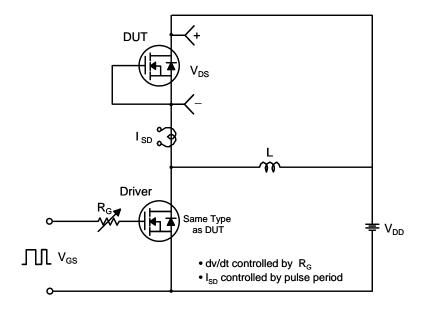
## **Resistive Switching Test Circuit & Waveforms**

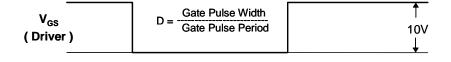


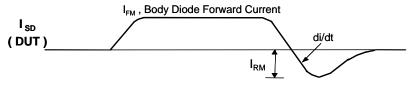
# **Unclamped Inductive Switching Test Circuit & Waveforms**



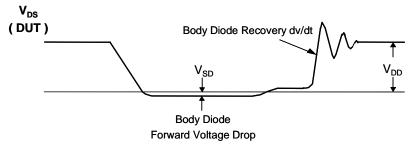
### Peak Diode Recovery dv/dt Test Circuit & Waveforms

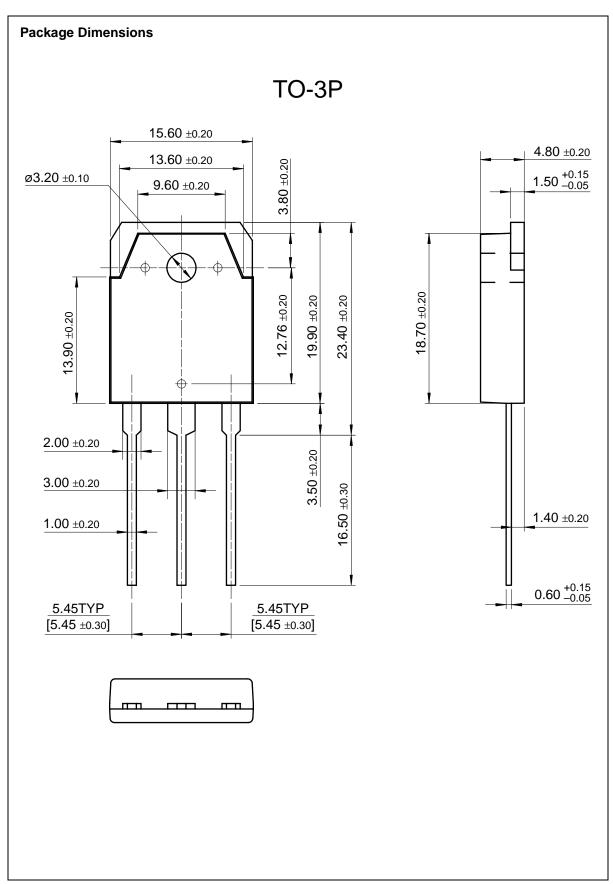






Body Diode Reverse Current





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